Hybrid intelligent approach for modeling and optimization of semiconductor devices and nanostructures

Yiming Li

Department of Communication Engineering, National Chiao Tung University, 1001 Ta-Hsueh Road, Hsinchu 300, Taiwan

Abstract

In this work, we present a hybrid intelligent approach for parameter extraction and design optimization of semiconductor nanoscale devices and nanostructures. Based on evolutionary algorithms, numerical methods, neural network scheme and parallel computing technique, the optimization methodology is developed and successfully implemented. In the hybrid approach, an evolutionary algorithm, such as genetic algorithm or particle swarm optimization, firstly searches the entire problem space to get a set of roughly estimated solutions. The numerical method, such as Levenberg–Marquardt method, then performs a local optima search and sets the local optima as the suggested values for the genetic algorithm to perform further optimizations. Meanwhile, the neural network is applied to investigate the influence of parameters on the optimized functions which thus guides the evolutionary direction of genetic algorithm. For solving real world problems, all functional blocks are performed under a PC-based Linux cluster system with message-passing interface libraries. This hybrid intelligent approach has experimentally been implemented and validated for different applications in semiconductor nanodevices and nanostructures. For semiconductor nanodevice parameter extraction, this approach shows its capability to automatically extract a set of global parameters among sixteen 90 nm complementary metal oxide semiconductor (CMOS) devices. Compared with the measured current–voltage ($I$–$V$) curves of fabricated CMOS samples, the optimized $I$–$V$ results are within 3% of accuracy. The computational examinations including sensitivity, convergence property, and parallelization are discussed. For parameter extraction of organic light emitting diode (OLED), the approach also achieves good accuracy for red, green, blue OLEDs. For the third and fourth applications, optimal structure design of silicon photonic taper waveguide and photonic crystal are further advanced by integrating a simulation-based technique in the developed system. All of these experiments demonstrate interesting results and validate the optimization methodology. The concept of hybrid intelligent approach may benefit modeling and optimization in diverse science and engineering problems.

1. Introduction

Model and optimal parameters have been at the heart of computer-aided design tools (CAD) for semiconductor technology over the past decades. In the modern microelectronics industry, parameters of the semiconductor nanodevices and nanostructures are tuned by engineers for matching some specifications. To satisfy the design targets, engineers must base on the simulation result of CAD tools to adjust the design parameters, and again feed the adjusted parameters to retrieve improved results. Currently, this mechanical procedure is mostly performed by engineers empirically. Numerical and evolutionary methods have been studied in the characteristic optimization of semiconductor devices [1–6], but numerical methods in general require an accurate initial guess to perform a local optimization. Solution with a pure evolutional method suffers a long time evolution process. It may take days even weeks to find suitable parameters for the designed devices.

In the semiconductor technology, the equivalent circuit models [7] continuously play an active role in bridging the nanodevice fabrication and integrated circuit (IC) design. As the mainstream complementary metal-oxide-semiconductor (CMOS) technology is scaled into the nanoscale regime, hundreds of parameters have to be optimized and extracted for the corresponding model equations. For optical devices and semiconductor nanostructures, such as organic light emitting diode (OLED), silicon photonic taper waveguide and photonic crystal, there are also many parameters related to the device structure should be adjusted for better performance. Conventional manual adjustment will be a bottleneck for design of advanced semiconductor materials and nanodevices.
Moreover, either the numerical or evolutionary optimization techniques have limitation for such complicated engineering problems. Therefore, an accurate and robust hybrid intelligent approach may benefit the advanced optimization problems.

In this work, we practically implement a flexible hybrid intelligent approach for optimization problems in semiconductor nanodevice and nanostructures. Based on evolutionary algorithms, advanced numerical methods, adaptive neural network scheme and parallel computing techniques, a hybrid optimization methodology is proposed and successfully implemented in the unified optimization framework (UOF) [5,8–12]. In the proposed hybrid approach, a multiobjective distributed evolutionary algorithm, such as genetic algorithm (GA) or particle swarm optimization (PSO) is firstly executed for a rough estimation on the solution, the numerical method, such as Levenberg–Marquardt (LM) method will enable a local optimization, where the adaptive neural network (NN) investigates the quality of solutions and suggests searching directions for the GA. Our preliminary investigation shows that this optimization methodology empirically solves diverse optimization and parameter extraction problems arising from semiconductor nanodevices and nanostructures in a computationally cost-effective manner. For semiconductor nanodevice parameter extraction (is also known the parameter optimization), this approach shows its capability to automatically extract a set of global parameters among sixteen 90 nm CMOS devices. Compared with the measured I–V curves of fabricated samples, the optimized results are within 3% of accuracy. The computational examinations including sensitivity, convergence property, and parallelization are discussed. Efficiency comparison among the pure evolutionary algorithms, pure numerical methods, and the hybrid intelligent approach are also verified in this example. For parameter extraction of OLED devices [13–16], the approach also achieves good accuracy for red, green, blue OLEDs. For the third and fourth applications, optimal structure design of silicon photonic taper waveguide [17–21] and photonic crystal [22] are further advanced by integrating a simulation-based technique in the developed system. All of these experiments demonstrate interesting results and validate the optimization technique. The concept of hybrid intelligent approach may benefit modeling and optimization in diverse science and engineering problems.

This paper is organized as follow. In Section 2, we describe the concept of the proposed hybrid intelligent approach. In Section 3, we show the computer experimental results for the parameter extraction and structure optimization of four different problems in semiconductor nanodevices and nanostructures. Finally, we draw conclusions and suggest future work.

2. The optimization methodology

In this section, we state the details of the proposed hybrid intelligent approach. Fig. 1a shows an illustration of the proposed optimization system. The system is composed of preprocess, extraction engine and postprocess. In the preprocess, available empirical rules are employed to initiate the parameters to be optimized which are depending on the different problems of semiconductor nanodevices and nanostructures. If necessary, the data reduction will be performed in the preprocess. For example, the parameter extraction of the equivalent circuit models for the CMOS technology often involves four or six sets of I–V curves (under different bias conditions); and each set of I–V curves consists of five I–V lines, each of which has at least thirty I–V points. When performing the global extraction with multiple transistors, such as 16, 32, or more devices, the number of I–V points increases significantly. Therefore, a statistical data reduction can significantly reduce the computational complexity during the optimization process. After the preprocess, the extraction engine that integrating such as GA, NN, numerical approach and parallelization technique, then performs the optimization and parameter extraction process for an interesting semiconductor nanodevices and nanostructures. The electrical and physical quantities verification is finally performed in the postprocess.

The extraction engine is the core of optimization and parameter extraction. It contains the numerical optimization method, genetic algorithm, neural network, and the parallelization technique. We have successfully implemented this hybrid approach in the UOF. In the following sub-sections, the concepts of GA, NN, LM, and the proposed hybrid intelligent methodology are stated briefly.

2.1. The evolutionary and numerical approaches

The evolutionary approaches including GA and NN are employed in the proposed system. It is known that a GA is a globally searching optimization method which is based on the mechanism of natural selection and natural genetics. It works with a code of parameter strings called chromosome instead of the solutions themselves. Each chromosome represents a solution set, and the fitness functions are adopted to measure the survival scores of all chromosomes in the population. Then the GA will accord its selection scheme to select several chromosomes for reproduction, discard unwanted chromosomes, and select the crossover scheme to produce the new generation. Then the GA will apply fitness func-
tation for the new population again and loop this cycle until certain stop criteria is achieved [3–6]. It is known that NN is an adaptive learning network which has a remarkable ability to derive meaning from complicated or imprecise data. It has been widely used in various ranges, especially in pattern reorganizations and the image processing. In this work, we adopt Hamming net to guide GAs to search the better solutions. The Hamming net is a supervised feedback NN which contains two sub-networks, the matching score net and the maximum net. When the training patterns stores into matching score net, it measures the differences between input patterns and training patterns. After grabbing the output of each node in the matching score net, the maximum net is functioned to determine which training pattern is the most similar to the input pattern. Once there is a unique restrained output above the threshold, the Hamming net terminated, and considers the training pattern represented by the node which provided the outstanding output is most similar to the input pattern, thus the input pattern can be clustered into this training pattern.

We notice that NN is applied to investigate the influence of parameters to the optimized functions, and guides GAs to focus on some major parameters to obtain better solutions instead of performing blind search. In contrast with the GA and NN above, numerical optimization method, such as LM method is a quasi-Newton method to accelerate the Gauss–Newton method. The Gauss–Newton method is the basic algorithm for solving the nonlinear optimization problem. Due to the nonlinear property of the problem, a gradient for each variable could be obtained. It starts from an initial guess, and follows the direction of the normal of the gradient to find the optimal solution. Therefore, the initial guess must be chosen carefully, or the solution may fall into a local optima. Unlike the Gauss–Newton method has the fixed steps toward the solution, LM optimization method detect that some regions with monotonic variation property which can be accelerated by increasing the step size. On the other hand, when the optimization process encounters a sensitive region, the step should be shortened to avoid skipping the optimum.

2.2. The hybrid intelligent approach

An execution flowchart of the hybrid intelligent technique for the parameter extraction task is shown in Fig. 1b. The GA, as shown in this figure, firstly searches the entire problem space to get a set of roughly estimated solutions. After a roughly computed solution is obtained, the LM method performs a local optima search and sets the local optima as the suggested values for the GA to perform further optimizations. Meanwhile, the NN is applied to investigate the influence of parameters on the optimized functions, and guides the GA to focus on those significant parameters to obtain the better solutions instead of performing blind search.

Taking the parameter extraction of 90 nm CMOS devices as an example, the NN compares the difference of the physical characteristics of the measured data and the simulated $I–V$ curves. According to the examined results of the original and the computed first derivatives of $I–V$ curves, the NN will suggest that the GA should focus on the evolution of those corresponding parameters. Conventional GA-based methods are plagued by problems such as rapid decreases in the population diversity and disproportionate exploitation and exploration of the solution space with multiple dimensions. The results are frequent premature convergence and inefficient search. Compared with the pure GA-based optimization techniques, the LM method finds a solution rapidly with an accurate initial guesses. We have to note that the LM method, a modified Gauss–Newton method, is still a local method and is easily trapped into local optima. With a proper integration of the LM method in the optimization process, the GA saves much unnecessary efforts to search optima. Furthermore, the most significant parameters that influence physical quantities of CMOS devices have also been detected and monitored. If physical quantities are intolerant, other electrical characteristics will also lose their accuracy. Therefore, the parameters which affect those major quantities should be extracted firstly and the priority of optimization sequence of the model parameters should be considered. Besides, each physical quantity affects some specified $I–V$ curves characteristics such that we can be conscious of the intolerance of physical quantities through investigating the characteristics of $I–V$ curves.

The information described above is built in the NN. Under the guidance of the NN, the GA emphasizes the most important parameters and corrects physical quantities one by one. Taking GA as the evolutionary algorithm, a pseudo code for the hybrid system, shown in Fig. 1b, is listed below.

```
Begin Hybrid Optimization Algorithm
Begin GA Optimization
Initialize GA
While EstimatedError(BestSolution) > ToleranceError
   GA Performs Optimization
   NN ModelInspection(BestSolution)
   LM Optimization(BestSolution)
End While
End GA Optimization
End Hybrid Optimization Algorithm
```

For practical implementation, we notice that the hybrid intelligent approach could be carried out conveniently in the environment of UOF, which was recently developed by us and is available on line [12]. Diverse solvers including the aforementioned GA, NN and LM methods are already developed in the platform of UOF; and we only need to integrate them to construct the hybrid approach. Before discussion on the potential application in optimization problems of semiconductor nanodevices and nanostructures, a benchmark problem is firstly examined with the hybrid intelligent approach for the accuracy and efficiency examination. Consider the following minimization problem

$$
\text{Min} f(x_1, x_2) = 21.5 + x_1 \sin(4 \pi x_1) + x_2 \sin(20 \pi x_2)
$$

where $-3.5 \leq x_1 \leq 12.1$ and $4.1 \leq x_2 \leq 5.8$. The objective function to be minimized oscillates periodically within the constraint range.

**Table 1** shows the optimized solutions by four different optimization methods. According to the achieved results, we find that the numerical method cannot find the global minimum. Without a good initial guess, it is impossible to solve this problem using LM method. The hybrid intelligent approach provides a most computationally effective way to obtain the optimal solution. Nevertheless, the GA or GA + NN approach can also find a good solution with much more longer time for evolutionary iterations. The hybrid intelligent approach empirically demonstrates excellent computational efficiency in solving this minimization problem. More details related to computational cost, such as gradient calculation and population size effect could be addressed somewhere else.

3. Results and discussion

Applications of the hybrid intelligent approach in semiconductor nanodevices and nanostructures are presented in this section. In the first, an examination of the optimization methodology on the parameter extraction for sixteen 90 nm CMOS devices is...
performed. The extracted results confirm that the methodology is superior to other approaches. In the second application, an equivalent circuit model is for the first time proposed for the OLED and then the corresponding parameters are optimized. The first two applications are the so-called equation-based optimization problems. By integrating numerical simulation kernels with the hybrid intelligent approach, a simulation-based optimization technique is also implemented for the structure optimizations of the silicon photonic taper waveguide and the photonic crystal. The involved simulators in these two problems are including MPB [23] and CAMFR [24] for solving the Maxwell equations.

### 3.1. Parameter extraction for sixteen 90 nm CMOS devices

Mathematically, model parameter extraction is a multidimensional nonlinear optimization problem, where the number of parameters could be larger than 100. The main goal of device model parameter extraction is to minimize the error between the extracted result and the measurement, where the extracted result is obtained through the equation below:

\[ f(x_{\text{ex}}, x_v) = I_D(p, v, d), \]

where the \( f(x_{\text{ex}}, x_v) \) is the \( I-V \) functions (e.g., \( I-V \) points) to be optimized; the \( I_D \) is a selected compact model, which contains more than 40 subequations in the BSIM model [5–6], for example. Vectors \( p, v \) and \( d \) are parameter vectors. The function to be minimized is a cost function, \( f(x_{\text{ex}}, x_v) \), which can be expressed as the following equation:

\[ f(x_{\text{ex}}, x_v) = I_D(p, v, d) - I_{\text{meas}}. \]

Table 1

<table>
<thead>
<tr>
<th># of iterations</th>
<th>Levenberg–Marquardt method</th>
<th>GA</th>
<th>GA + NN</th>
<th>The hybrid approach</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>11.54</td>
<td>11.54</td>
<td>11.54</td>
<td>11.54</td>
</tr>
<tr>
<td>10</td>
<td>9.48</td>
<td>10.09</td>
<td>10.61</td>
<td>9.850</td>
</tr>
<tr>
<td>20</td>
<td>8.72</td>
<td>9.946</td>
<td>9.483</td>
<td>8.103</td>
</tr>
<tr>
<td>40</td>
<td>8.72</td>
<td>8.054</td>
<td>7.481</td>
<td>6.944</td>
</tr>
<tr>
<td>60</td>
<td>8.72</td>
<td>5.984</td>
<td>5.324</td>
<td>3.853</td>
</tr>
<tr>
<td>100</td>
<td>8.72</td>
<td>4.015</td>
<td>3.923</td>
<td>–</td>
</tr>
</tbody>
</table>

Fig. 2. Plot of the function to be optimized \( f(x_1, x_2) \) respect to \( x_1 \) and \( x_2 \).

Fig. 3. Plot of the developed weight function for the calculation of fitness.

Fig. 4. The dimension distribution (width versus length) of investigated 16 devices. The dimension of the smallest device is \( l = 90 \) nm and \( W = 0.6 \) μm.
Fig. 5. The extracted (lines) and measured (dots) $I_{DS}$–$V_{DS}$ curves of the 90 nm nMOSFETs. The errors of all devices are within 3%.

Fig. 6. The extracted (lines) and measured (dots) $I_{DS}$–$V_{GS}$ curves of the 90 nm nMOSFETs. The errors of all devices are within 3%.
curves with respect to $V_{DS}$ of the 90 nm nMOSFETs corresponding to $I_{DS}$–$V_{GS}$ curves in Fig. 5. The errors of all devices are within 5%. The notation $g_D$ means the channel conductance of the device which is the partial derivative of drain current $I_{DS}$ with respect to the drain voltage $V_{DS}$ [25].

and $d$ are the parameter sets to be extracted, the bias condition for simulation, and the device geometry, respectively. There are at least 50 $I$–$V$ points forming an $I$–$V$ curve, 5 $I$–$V$ curves forming a set of $I$–$V$ curves, and 4 sets of $I$–$V$ curves to characterize a single device behavior. When perform a model parameter extraction with 16 devices as target, there are 16,000 $I$–$V$ points need to be minimized, and the number of parameters is more than 100. Therefore, this parameter extraction problem is a large scale optimization problem with massive computation.

To validate the computational efficiency and accuracy of the developed hybrid approach, sixteen 90 nm n-type metal-oxide-semiconductor field effect transistors (nMOSFETs) have been fabricated, measured, and extracted. According to the nature of $I$–$V$ curves of devices, a physical-based weight function is developed for the calculation of fitness. Fig. 3 shows the proposed weight function. Fig. 4 shows the dimension distribution (the device width $W$ versus its length $L$) of the investigated sixteen nMOSFETs of 90 nm fabrication technology. The equivalent circuit model used in this examination is the BSIM4 model [6]. Figs. 5 and 6 show the extracted drain current–drain voltage ($I_{DS}$–$V_{DS}$) and $I_{DS}$–$V_{GS}$ curves of the 90 nm nMOSFET, and the error of all cases are less than 3%. Figs. 7 and 8 are the first derivatives of the original $I$–$V$ curves with respect to $V_{DS}$ and $V_{GS}$ where all computed errors are within 5%. We notice that the computed accuracy is good enough according to the device modeling point of view in semiconductor industry. Comparison between the measurement data (dots) and the simulation (lines) demonstrates good accuracy of the optimization method. The first derivatives of all sets of curves of $I_{DS}$–$V_{DS}$ and $I_{DS}$–$V_{GS}$ with respect to the different applied voltages are calculated by

$$g_D = \frac{\partial I_{DS}}{\partial V_{DS}} \quad \text{(3)}$$

and

$$g_m = \frac{\partial I_{DS}}{\partial V_{GS}} \quad \text{(4)}$$

We notice that the partial derivative of drain currents with respect to $V_{DS}$ and $V_{GS}$ is physical meaningful which represents important electrical quantities in semiconductor device physics [25]: $g_D$ is the channel conductance (also called the drain conductance) and $g_m$ is the transconductance. These results confirm the accuracy of the hybrid intelligent approach in the multiple nanoscale CMOS device parameter extraction.

Table 2 shows the extraction time of various number of CMOS devices with respect to different extraction approaches. As shown in Table 2, if the devices number is less than eight, the hybrid intelligent approach has similar extraction time, compared with other methods. However, when the number of devices greater than 8 or 16, the hybrid intelligent approach demonstrates better extraction efficiency, compared with other methods. In our hybrid system, the time acquired by the numerical LM method and neural network algorithm can be regarded as instant, compared with the time cost of GA. Therefore, only the GA is required a parallelization technique. Application of parallelization to GA provides an efficient way to reduce the computing time [9,10]. Fig. 9b shows the archived speedup for different number of devices when perform parallelization of GA. We found that when the devices number is less than 8, then the parallelization on an 8 node cluster is enough. However, if the devices number is equal to 16, then the 16 node cluster is more suitable and can provide better speedup.
The structure of OLED has multilayer of materials. To model the characteristics of OLEDs, we should consider the effect of high built-in voltage existing among the layers of organic materials and the effect of the nonideal ohmic that occurs on the contact between metal and organic. The equivalent circuit of the OLED model is corresponding optimized parameters show the good accuracy. To perform the sensitivity analysis, the proposed system extracts single category of parameters meanwhile locks other sets of parameters. The expected result should show that varying certain parameters would make notable progress while some others would not. Fig. 9a reveals that the parameters related to the threshold voltage would make the most improvement. With the similar methodology, the silicon photonic taper waveguide optimization and the photonic crystal design optimization are conducted. We notice that for these two examinations, we only empirically enable GA or PSO methods in the hybrid system due to the less parameter scales of guiding region is an important role in an integrated optic.

### 3.2. Modeling and parameter extraction of OLED devices

In this subsection, we present a new equivalent circuit model for OLED and then apply the hybrid system for the parameter extraction. The physical-based OLED model is considering the effect of high built-in voltage existing between the organic materials and the organic layers. Compared with the measured I-V data of red, green, and blue (RGB) OLED samples, the new OLED model and the correspondingly optimized parameters show the good accuracy. The structure of OLED used in our model parameter extraction, sample fabrication and measurement is shown in Fig. 10a. The structure of OLED has multilayer of materials. To model the I-V characteristics of OLEDs, we should consider the effect of high built-in voltage existing among the layers of organic materials and the effect of the nonideal ohmic that occurs on the contact between metal and organic. The equivalent circuit of the OLED model is shown in Fig. 10b, where the effect of high built-in voltage and the nonideal ohmic effect are modeled with the variable resistance and the supplied battery. A nonlinear resistance is adopted to reflect the phenomenon of the Schottky barrier. With adding those two items into the ideal diode model, the OLED model can be directly incorporated into SPICE circuit simulator without any convergence problems, where a copy of SPICE net list is shown in Fig. 10c. The parameters of the OLED model are listed in Table 3. Fig. 11 shows the comparison results between the extracted results and the measured RGB OLED data, respectively. The modeling and parameter extraction presents good accuracy when describes the OLED physical characteristics in both the cut-in and on-state regions.

**Table 2**

Comparison of computational efficiency among different approaches

<table>
<thead>
<tr>
<th># of devices</th>
<th>GA</th>
<th>GA + LM</th>
<th>GA + NN</th>
<th>The hybrid approach</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0.0</td>
<td>122.7</td>
<td>102.3</td>
<td>172.5</td>
</tr>
<tr>
<td>2</td>
<td>478.4</td>
<td>419.7</td>
<td>437.1</td>
<td>452.5</td>
</tr>
<tr>
<td>4</td>
<td>5843</td>
<td>5621.9</td>
<td>5019.3</td>
<td>5123.6</td>
</tr>
<tr>
<td>8</td>
<td>23808.4</td>
<td>20018.6</td>
<td>19873.1</td>
<td>17230.2</td>
</tr>
<tr>
<td>16</td>
<td>150479.5</td>
<td>120975.1</td>
<td>109844.3</td>
<td>98201.3</td>
</tr>
</tbody>
</table>

We notice that the population size is equal to 100 and the mutation rate is 0.05 in GA among different approaches.

A taper structure to couple photonic devices with different scales of guiding region is an important role in an integrated optic.
Low-loss couplings which provide a large misalignment tolerance between single-mode fibers and photonic semiconductor devices are indispensable for photonic integrated circuits. Tapered waveguides can also be used for input/output coupling to single mode fibers and for semiconductor laser amplifier applications. For a linear tapered waveguide, we usually need a long length to decrease the optical loss. In this subsection, high transmittance silicon (Si) photonic taper waveguide is for the first time obtained by using PSO and GA methods in the hybrid system. With the evolutionary algorithms, optimization of the photonic taper waveguide structure is achieved. More than 99.5% transmittance is obtained with the electromagnetic simulation and evolutionary algorithms.

Fig. 12 shows the typical lateral taper waveguide structure for optimization. The width of the guiding layer is 3 μm initially and is reduced to 0.5 μm at the end of the taper. We firstly fix the taper length to be 10 μm and partition it into ten discrete width profiles for the structure optimization. By assuming the monochromatic fields that vary harmonically in time according to \( e^{jwt} \), a set of Maxwell’s equations is numerically solved in the loop of optimization:

\[
\nabla \times E = -j\omega B
\]

### Table 3

The parameter list of the OLED model

<table>
<thead>
<tr>
<th>Name</th>
<th>Description</th>
<th>Name</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>IS</td>
<td>Saturation Current</td>
<td>N</td>
<td>Emission coefficient</td>
</tr>
<tr>
<td>ISW</td>
<td>Sidewall saturation current</td>
<td>RS0</td>
<td>Ohmic resistance</td>
</tr>
<tr>
<td>IK</td>
<td>Forward knee current</td>
<td>Vbi</td>
<td>Built-in potential</td>
</tr>
<tr>
<td>IKR</td>
<td>Reverse knee current</td>
<td>VBH</td>
<td>Barrier height</td>
</tr>
</tbody>
</table>

### Fig. 11

Comparison between the measurement (lines) and model (dashed line) of the I–V curves for the (a) red, (b) green and (c) blue OLED devices. (d)–(f) are the I–V curves in log scale.
\[ \nabla \times H = J + jwD, \]
and
\[ \nabla \cdot D = \rho \quad \text{and} \quad \nabla \cdot B = 0, \]

where \( E \) is the imposed electric field, \( B \) is the magnetic field, \( H \) is the effective magnetic field inside the dielectric, \( D \) is the effective electric field inside the dielectric, \( J \) is the free current density, and \( \rho \) is the charge density. An eigenmode expansion simulation approach is adopted [21]. Its computational speed is faster than the traditional finite difference time domain method. In order to obtain the optimized structure with minimum propagation loss, the evolutionary algorithms GA (or PSO) will optimize the 10 parameters to obtain the best performance of the taper waveguide. Our target in this case is to maximize the transmittance. In the GA kernel we set 10 population sizes for each generation. The fitness function is well chosen for maximized the transmission efficiency. The PSO kernel of all the optimizations in this study is constructed based on the iterative formulas that control the swarm behaviors:

\[ V_t = wV_{t-1} + k_1 \eta_1 (P_{t-1} - X_{t-1}) + k_2 \eta_2 (G_{t-1} - X_{t-1}) \]

and

\[ X_t = X_{t-1} + V_t \Delta t, \]

where \( w \) is the inertia factor, \( k_1 \) is the competition factor, \( k_2 \) is the cooperation factor, \( G \) is the global best and \( P \) is the local best. Also the \( X \) is the position at the time step and \( V \) is the velocity of the particle. In each optimization step, the GA (or PSO) gives the initial condition for the computation kernel. The fitness function will be calculated by the return transmission efficiency. Iteratively the GA (or PSO) gives the new parameter set until reach the goal. The transmittance is given by

\[ \text{transmittance} = \frac{\text{Power}_{\text{output}}}{\text{Power}_{\text{input}}} \times 100\%. \]

Fig. 12. A three-dimensional schematic diagram of the studied silicon taper waveguide.

Fig. 13. (a) Field distribution of the optimized results by GA, where the transmittance is about 94.5% (b) and field distribution of the optimized results by PSO, where the transmittance is about 99.5%.

Fig. 14. The convergence property of the (a) GA and PSO methods. We notice that PSO takes 10 times iterations compared with the iterations of GA.
The transmittance will be 100% for a perfect structure; however, the critical point is the dimension of the cross section at the interface. There is a tradeoff between the small area and the maximum transmittance. We implement the GA and PSO algorithms in the hybrid system to optimize the 10 parameters for maximizing the transmission efficiency. The Fig. 13a shows the optimized results by GA, the optimized parameters are 2.576, 5.815, 2.131, 1.923, 1.458, 4.273, 2.468, 0.871, 1.954, and 0.719. The calculated transmittance is about 94.5%. Also we show the PSO results in Fig. 13b. The optimized parameters are 4.850, 5.697, 5.298, 3.432, 3.065, 1.744, 1.482, 2.251, 2.485, and 0.797. The transmittance is about 99.5%. As shown in Fig. 14, we show the convergence property of the GA and PSO methods. The proposed GA and PSO show very good efficiency to do the optimization problems. The CPU time versus the number of iteration is reported in Fig. 15a, and the transmission increases when the number of iteration increases for the PSO optimization, as shown in Fig. 15b.

3.4. Photonic crystal design optimization

A 90° splitter in square lattice of GaAs rod in the air is optimized [22]. Fig. 16a shows the original profile of the explored photonic crystal, where the total length is about 6.6 μm and the width is about 3 μm; and the corresponding field distribution of the structure is shown in Fig. 16b. The period of the structure is 0.6 μm and the rod radius is about 75 nm. The transmittance of the original profile is equal to 44.7%. To increase the transmittance of the explored structure of photonic crystal, we optimize the profile of the photonic crystal using the hybrid system. As shown in Fig. 16c and d, the optimized profile and the corresponding field distribution are obtained. A better transmittance, about 95.2%, is achieved.

4. Conclusions

In this paper, based upon the evolutionary algorithms, the numerical methods, the neural network scheme, and the parallel computing technique, we have developed and practically implemented a hybrid intelligent approach for optimization problems of semiconductor nanodevices and nanostructures. This optimization methodology has been successfully implemented in our unified optimization framework. The developed open-source project is available in the public domain. For the studied sixteen 90 nm CMOS technology, this approach demonstrates its capability to extract a set of optimal parameters from several sets of measured I–V curves of fabricated MOSFETs globally. We notice that there are no similar publications about the 90 nm CMOS device parameter extraction problem with completely experimental data. It is thus difficult to make a comparison with other works; therefore, we have directly compared the optimized results with the experimen-
tally measured data of our fabricated samples. Compared with the fabricated and measured data, the errors of optimized results are less than 5%. This accuracy is good enough for the device model point of view in semiconductor industry. Application of the hybrid system to RGB OLED devices has also been discussed. Besides, optimal structure designs of silicon photonic taper waveguide and photonic crystal have further been advanced using a simulation-based optimization methodology. This hybrid intelligent approach not only benefits the modeling and optimization of semiconductor nanostructures and devices but also can be extended for other real world applications. The similar methodology can be used for 65 nm CMOS device parameter extraction. We are currently extended this work for sub-45 nm CMOS device parameter extraction including using the surface potential based models.

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